Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/824,366	LEE, CHANG LIM	
Examiner	Art Unit	
B. Clayton McCraw	3744	

SEARCHED					
Class	Subclass	Date	Examiner		
138	110	4/26/2006	всм		
138	110	11/10/2006	всм		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted with Primary Examiner, William Doerrler	4/26/2006	всм		
Consulted with Primary Examiner, James Hook	4/26/2006	всм		
Conducted Inventor Name Search	4/26/2006	всм		
EAST Search Notes Attached	4/26/2006	всм		
Consulted with Primary Examiner, William Doerrler	11/1/2006	всм		